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## **Design of a Low-Noise, Charge Sensitive Amplifier for MCP-PMT Detector Readout**

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Readout of micro-channel plate detectors using cross strip anodes require low noise, fast charge sensitive amplifier (CSA) front-end electronics. The goal of this CSA project is to improve noise and shaping time from the "PreShape32" amplifier ASIC of the RD-20 collaboration at CERN, presently used in the readout system. A target noise of  $100e^- + 50e^-/\text{pF}$  ( $<1000e^-$  noise overall) with  $<100\text{ns}$  shaping time is desired. Overall gain should be better than  $5\text{mV}/\text{fC}$ . Two amplifiers have been manufactured and tested (CSAv1 and CSAv2) with a third presently being designed. All have been designed using a 130nm IBM CMOS process.

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